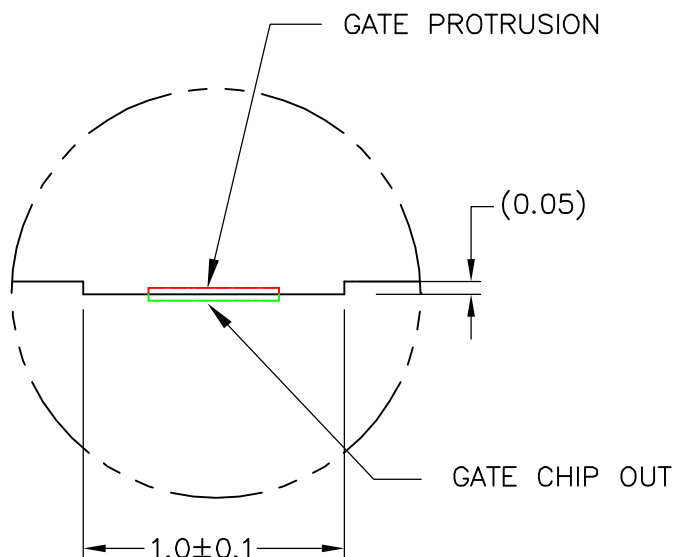


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<b>TITLE:</b> TEPBGA-I 27 X 27 X 2.23 PKG 1 MM PITCH, 416 I/O	DOCUMENT NO: 98ASA00493D      REV: A	STANDARD: JEDEC MS-034    AAL-1
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DETAIL A

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NOTES:

1. ALL DIMENSIONS IN MILLIMETERS.
2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
3. MAXIMUM SOLDER BALL DIAMETER MEASURED PARALLEL TO DATUM A.
4. DATUM A, THE SEATING PLANE, IS DETERMINED BY THE SPHERICAL CROWNS OF THE SOLDER BALLS.
5. PARALLELISM MEASUREMENT SHALL EXCLUDE ANY EFFECT OF MARK ON TOP SURFACE OF PACKAGE.
6. GATE PROTRUSION HEIGHT OR CHIP OUT DEPTH: MAXIMUM 0.049mm.

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